Claims

[c1] 1. A method of forming a gas dielectric with support structure comprising the steps of:

providing a conductive structure in a wiring-layer dielectric;

forming a support connected to the conductive structure, the support including an area thereunder; and

removing the wiring-layer dielectric from the area to form a gas dielectric.

[c2] 2. The method of claim 1, further comprising the steps of:

providing the conductive structure as a first interconnect; and

providing a second interconnect in spaced relation away from the first interconnect in the wiring-layer dielectric, wherein the support forms a bridge connecting the first interconnect with the second interconnect.

[c3] 3. The method of claim 2, wherein the bridge is formed coplanar with a top surface of the first interconnect and the second interconnect.

[c4] 4. The method of claim 2, further comprising the steps of:

providing a via-layer dielectric layer;
providing the wiring-layer dielectric on the via-layer
dielectric; and
removing a portion of the via-layer dielectric,
wherein the gas dielectric surrounds the bottom of
the first interconnect and the second interconnect.

- [05] 5. The method of claim 1, wherein the support is formed coplanar with a top surface of the conductive structure.
- [c6] 6. The method of claim 1, wherein the support includes a dielectric material.
- [c7] 7. The method of claim 1, further comprising the steps of:

providing a via-layer dielectric; providing the wiring-layer dielectric on the via-layer dielectric; and removing a portion of the wiring-layer dielectric, wherein the gas dielectric surrounds a portion of a bottom of the conductive structure.

[08] 8. The method of claim 1, wherein forming the support further comprises the steps of:

forming a stopping layer on the wiring-layer dielec-

tric;

forming a sacrificial layer on the stopping layer; selectively removing a portion of the sacrificial layer, the stopping layer, and the wiring-layer dielectric for placement of the conductive structure;

forming a vertical sacrificial spacer in the portion selectively removed to surround a portion of the conductive structure;

forming the conductive structure between the vertical sacrificial spacer;

partially removing the conductive structure substantially coplanar to a top surface of the sacrificial layer; removing the sacrificial layer and a top portion of the vertical sacrificial spacer; and

forming a support with the stopping layer and a material on the vertical sacrificial spacer, wherein the material is formed coplanar to a top surface of the stopping layer and connects to the conductive structure.

[09] 9. A semiconductor device structure comprising:

an underlying structure;

a conductive structure;

a support connected to and coplanar to a top surface of the conductive structure, the support including an area thereunder; and a gas dielectric in the area and surrounding a portion of the conductive structure.

- [c10] 10. The device structure of claim 9, wherein the conductive structure includes a wire.
- [c11] 11. The device structure of claim 9, wherein the conductive structure includes a first interconnect.
- [c12] 12. The device structure of claim 11, further comprising: a second interconnect in spaced relation away from the first interconnect on the underlying structure, wherein the support includes a bridge connecting the first interconnect with the second interconnect.
- [c13] 13. The device structure of claim 12, wherein the gas dielectric surrounds a bottom of the first interconnect and the second interconnect.
- [c14] 14. The device structure of claim 9, wherein the support includes a dielectric material.
- [c15] 15. The device structure of claim 9, wherein the gas dielectric surrounds a portion of a bottom of the conductive structure.
- [c16] 16. A method of forming a gas dielectric with support structure comprising the steps of:

 providing an underlying structure;

forming a via-layer dielectric on the underlying structure:

forming a wiring-layer dielectric on the via-layer dielectric;

forming a conductive structure in the wiring-layer dielectric;

forming a support connected to and coplanar to a top surface of the conductive structure, the support including an area thereunder; and removing the wiring-layer dielectric from the area to form a gas dielectric.

[c17] 17. The method of claim 16, further comprising the steps of:

providing the conductive structure as a first interconnect; and

providing a second interconnect in spaced relation away from the first interconnect in the wiring-layer dielectric, wherein the support forms a bridge connecting the first interconnect with the second interconnect.

- [c18] 18. The method of claim 16, wherein the conductive structure includes a wire.
- [c19] 19. The method of claim 16, wherein the support includes a dielectric material.

[c20] 20. The method of claim 16, further comprising the step of removing a portion of the via-layer dielectric, wherein the gas dielectric surrounds a portion of a bottom of the conductive structure.